

**PRODUCT SPECIFICATION**

**PS-7500**

Rev. **B**

**ORIGINAL**

**Title: Micro SD Card Connectors Product Specification**

**Part Number: GTFP08 SERIES**

**Description: Micro SD Card Connectors push-push type**

**Revisions Control**

Rev.	ECN Number	Originator	Approval	Issue Date
A	NE-12203	Debby Hung	Arron Lin	11/13/2012
B	NE-18028	Karen Su	Roger Tsai	01/30/2018



**Product Specification Origination**

Originator:	Date:	Checked by:	Date:	Approved by:	Date:
Karen Su	01/30/2018	Aqua Chou	01/30/2018	Roger Tsai	01/30/2018

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**PRODUCT SPECIFICATION****PS-7500****Rev. B****1. SCOPE**

This document contains specific electrical and mechanical requirements for Micro SD Card Connectors push-push type to insure functionality and reliability.

**2. APPLICABLE DOCUMENT**

- 2.1 EIA-364 Standard Test methods for electrical connectors
- 2.2 UL-STD-94 Tests for flammability of plastic materials for parts in devices and appliances.

**3. REQUIREMENT****3.1 DESIGN AND CONSTRUCTION**

Product shall be of the design, construction and physical dimensions specified on the applicable product drawing.

**3.2 Material and Finish****3.2.1 Housing**

- High temperature thermoplastic, UL94V-0
- Color: Black

**3.2.2 Contact**

- Copper Alloy
- Contact area: Selective Gold plating
- Solder area: Tin plating
- Under-plating: Nickel plating

**3.2.3 Shell**

- Copper Alloy or Stainless steel
- Under-plating: Nickel plating (Stainless steel only)

**3.3 Rating**

- Current rating: 0.5A max
- Voltage rating: 3.6V Max
- Operating Temperature: -40°C~ +85°C  
Storage temperature: -40°C to +85°C  
Humidity: 95% max. none condensing.

**PRODUCT SPECIFICATION****PS-7500****Rev. B****4. Performance and testing****4.1 Test Requirement and Procedures Summary**

Test Item		Requirement	Procedure
<b>1</b>	Examination of product	Meets requirements of drawing	EIA-364-18 Visual and dimensional inspection per product drawing.
<b>Electrical:</b>			
<b>2</b>	Low-level Contact Resistance	100mΩ max. initially ΔR 40 mΩ max. after test	EIA-364-23 Mate connector with dry circuit of 20mV, 10mA Max. Measure and record the resistance of the separate connector contact interface. (See 4.2)
<b>3</b>	Dielectric Withstanding Voltage	No voltage breakdown	EIA-364-20 1. Test Voltage: 500 VAC between adjacent terminals. 2. Duration: 1 minute
<b>4</b>	Insulation Resistance	1000 MΩ min. initially 100MΩ min. after test	EIA-364-21 Unmated to a compatible part 1. Test Voltage: 500 VDC between adjacent terminals. 2. Duration: 1 minute
<b>5</b>	Temperature Rise	ΔT=30°C Max.	EIA-364-70 method 1 Mate card and measure the temperature rise of contact, 0.5 A per contact.

Test Item		Requirement	Procedure
<b>Mechanical:</b>			
<b>6</b>	Durability	No appearance damaged.	EIA-364-09 Cycling: 10000 cycles Cycling rate: 10cycles/minute

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<b>7</b>	Mating Force	15 N max.	EIA-364-13 Constant speed: 25 mm/minute
<b>8</b>	Un-mating Force	1~15 N	EIA-364-13 Constant speed: 25 mm/minute
<b>9</b>	Vibration	No appearance damaged.	EIA 364-28 conditions IV Mate card and subjected to the following vibration conditions, for a period of 2 hours in each of 3 mutually perpendicular axes, with passing At DC 5V and 150mA max. during the test. Amplitude : 196.1m/s <sup>2</sup> {20G} Frequency : 10-2000Hz 5 minutes per 1 cycle, 10 cycles per 1 axis total 30 cycles per 3 axes.
<b>10</b>	Mechanical Shock	No appearance damaged.	EIA 364-27 conditions A Mate card and subjected to the following shock conditions. 3 mutually perpendicular axis, passing DC 5V and 150mA max. during the test. (Total of 18 shocks) Test pulse : Half Sine (3.44:11.3) Peak value : 490m/s <sup>2</sup> {50G} Duration : 11ms
<b>11</b>	Card Release Force	2N+/-1N	From the state of the card lock, Pull the card at the speed rate 25 ± 3 mm/minute.
<b>12</b>	Push in strength	No Damage	The card is inserted in the opposite direction and the load of 19.6N is added

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<b>Environmental:</b>			
<b>13</b>	Thermal Shock	No appearance damaged.	EIA 364-32C The card shall be mated and exposed to the following condition for 5 cycles. 1 cycle: a) $-55\pm 3^{\circ}\text{C}$ for 30 minutes b) $+85\pm 2^{\circ}\text{C}$ for 30 minutes Transit time shall be within 3 minutes, Recovery time 1~2 hours
<b>14</b>	Low Temperature Exposure	No appearance damaged.	The card shall be mated and exposed to the condition of $-40\pm 3^{\circ}\text{C}$ for 96 hours. Recovery time 1~2 hours
<b>15</b>	High Temperature Exposure	No appearance damaged.	The card shall be mated and exposed to the condition of $+85\pm 2^{\circ}\text{C}$ for 96 hours, less than 25% relative humidity. Recovery time 1~2 hours
<b>16</b>	Humidity	No appearance damaged.	EIA 364-31 Method II Test Condition A. Subject mated connectors: Temperature: $40\pm 2^{\circ}\text{C}$ Relative humidity: 90-95% RH Duration time: 96 hours. Recovery time 1~2 hours
<b>17</b>	Salt Spray Test	No appearance damaged.	EIA-364-26 condition A $5\pm 1\%$ salt solutions, at $35\pm 2^{\circ}\text{C}$ duration 48 hours. Connectors detached
<b>18</b>	Solderability	95% of immersed area must show no voids, pin holes.	Contact solder tails into the molten solder (held at $245\pm 5^{\circ}\text{C}$ ) up to 0.5mm from the tip of tails for $3\pm 0.5$ seconds.

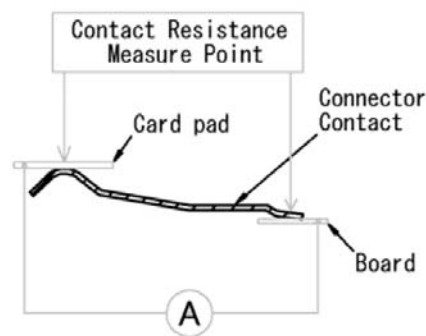
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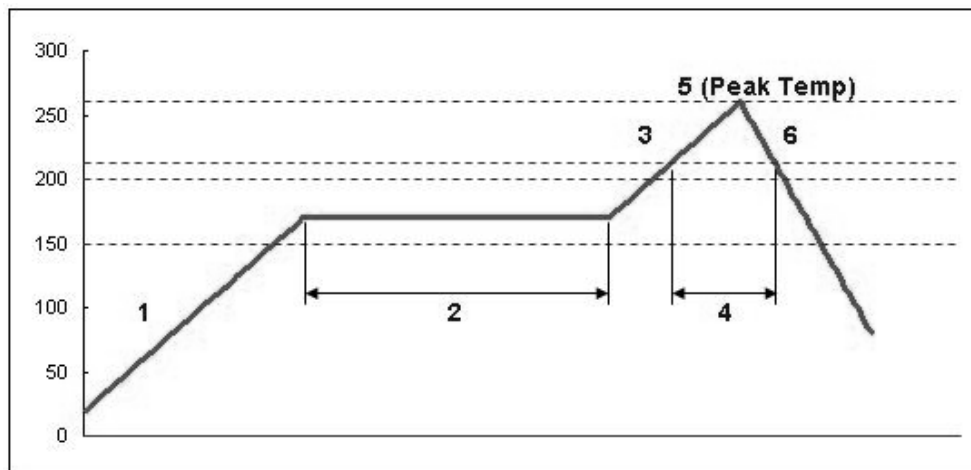
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<b>19</b>	Resistance to Soldering reflow Heat	No damage After 2 times of reflow	(refer to 4.3 Recommended IR reflow profile) Test condition: Peak temperature: 260+0 / -10 °C Preheating temperature: 150 – 200 °C, 60 to 120 sec.
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### 4.2 Contact Resistance Measurement Method



### 4.3 Recommended IR Reflow Profile(Lead-free)



<b>1</b>	Average ramp rate	3°C per second max.
<b>2</b>	Pre-heat temp.(minimum)	150°C
	Pre-heat temp.(maximum)	200°C
	Pre-heat time	60 to 120 seconds
<b>3</b>	Ramp to peak	3°C per second max.
<b>4</b>	Time over liquidus(217°C )	60 to 150 seconds
<b>5</b>	Peak temp.	260 +0/-10°C
	Time within 5°C of peak	10 seconds max.
<b>6</b>	Ramp- cool down	6°C per second max.
	Time 25°C to peak	8 minutes max.

**PRODUCT SPECIFICATION****PS-7500****Rev. B****5.0 TEST PROCEDURE**

Test or Examination		Test Groups								
		A	B	C	D	E	F	G	H	I
1	Examination of product	1,11	1,7	1,3	1,11	1,7	1,5	1,3	1,3	1,4
2	Low-level Contact Resistance	2,10	2,4,6		2,6,10	2,4,6	2,4			
3	Insulation Resistance				3,8					
4	Dielectric Withstanding Voltage	3,9			4,9					
5	Temperature Rise			2						
6	Mating Force	4,7								
7	Un-mating Force	5,8								
8	Durability	6								
9	Vibration		3							
10	Mechanical Shock		5							
11	Card Release Force									2
12	Push in strength									3
13	Low Temperature Exposure					3				
14	High Temperature Exposure					5				
15	Thermal Shock				5					
16	Salt Spray Test						3			
17	Solderability							2		
18	Humidity				7					
19	Resistance to Soldering reflow Heat								2	

Notes:

1. Test specimens: 5pcs/group

**List of Appendix**

- Product Drawing
- Qualification Test Report